IGBT - Field Stop, Trench 650 V, 60 A

FGH60T65SQD-F155

Description

Using novel field stop IGBT technology, ON Semiconductor's new series of field stop 4th generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

Features

- Max Junction Temperature 175°C
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.6 \text{ V} (Typ.) @ I_C = 60 \text{ A}$
- 100% of the Parts Tested for ILM(1)
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution
- This Device is Pb-Free and is RoHS Compliant

Applications

• Solar Inverter, UPS, Welder, Telecom, ESS, PFC

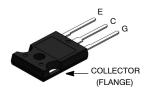


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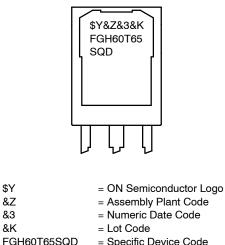
V _{CES}	Ι _C
650 V	60 A





TO-247-3LD CASE 340CH

MARKING DIAGRAM



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&Z

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&K

T65SQD	= Specific Device Code
100040	= openine Device dead

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

Symbol	Description		FGH60T65SQD-F155	Unit
V _{CES}	Collector to Emitter Voltage		650	V
V _{GES}	Gate to Emitter Voltage		±20	V
	Transient Gate to Emitter Voltage		±30	V
Ι _C	Collector Current	@ Tc < 25°C	120	А
		@ Tc < 100°C	60	
I _{LM} (Note 1)	Pulsed Collector Current @ Tc < 25°C		240	А
I _{CM} (Note 2)	Pulsed Collector Current		240	А
١ _F	Diode Forward Current@ Tc < 25°CDiode Forward Current@ Tc < 100°C		60	А
			30	А
I _{FM} (Note 2)	Repetitive Forward Surge Current		240	А
PD	Maximum Power Dissipation	@ Tc < 25°C	333	W
		@ Tc < 100°C		W
TJ	Operating Junction Temperature Range		–55 to +175	°C
T _{STG}	Storage Temperature Range		–55 to +175	°C
ΤL	Maximum Lead Temp. For soldering Pu	rposes, 18" from case for 5 sec	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. V_{CC} = 400 V, V_{GE} = 15 V, I_C = 240 A, R_G = 21 Ω, Inductive Load.
2. Repetitive rating: Pulse width limited by max. junction temperature.

THERMAL CHARACTERISTICS

Symbol	Parameter	FGH60T65SQD-F155	Unit
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case, Max.	0.45	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	1.25	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FGH60T65SQD-F155	FGH60T65SQD	TO-247-3LD	Tube	-	-	30

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS					
BV _{CES}	Collector to Emitter Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	650	-	_	V
$\Delta \text{BV}_{\text{CES}} / \Delta \text{T}_{\text{J}}$	Temperature Coefficient of Breakdown Voltage	I_{C} = 1 mA, Reference to 25°C	-	0.6	_	V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	_	_	250	μA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	-	-	±400	nA
ON CHARACTE	RISTICS				-	-
V _{GE(th)}	G-E Threshold Voltage	I_{C} = 60 mA, V_{CE} = V_{GE}	2.6	4.5	6.4	V
		I _C = 60 A _, V _{GE} = 15 V	_	1.6	2.1	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage	I _C = 60 A V _{GE} = 15 V, T _C = 175 [°] C	-	1.92	-	v
DYNAMIC CHA	RACTERISTICS			•	1	
C _{ies}	Input Capacitance		-	3813	_	pF
C _{oes}	Output Capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1MHz	_	90	_	pF
C _{res}	Reverse Transfer Capacitance		-	13	-	pF
SWITCHING CH	IARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$\label{eq:V_CC} \begin{array}{l} V_{CC} = 400 \; V, \; I_{C} = 15 \; A, \\ R_{G} = 4.7 \; \Omega, \; V_{GE} = 15 \; V, \\ Inductive \; Load, \; T_{C} = 25^\circ C \end{array}$	-	20.8	-	ns
tr	Rise Time		-	8	_	ns
t _{d(off)}	Turn–Off Delay Time		-	102	-	ns
t _f	Fall Time		-	11.2	_	ns
Eon	Turn-On Switching Loss		-	227	-	μJ
E _{off}	Turn–Off Switching Loss		-	100	_	μJ
E _{ts}	Total Switching Loss		-	327	-	μJ
t _{d(on)}	Turn–On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 30 \text{ A},$	-	21.6	_	ns
t _r	Rise Time	R_G = 4.7 Ω, V _{GE} = 15 V, Inductive Load, T _C = 25°C	-	14.4	-	ns
t _{d(off)}	Turn-Off Delay Time		-	97.6	_	ns
t _f	Fall Time		_	4.8	-	ns
Eon	Turn-On Switching Loss] [_	585	-	μJ
E _{off}	Turn–Off Switching Loss] [-	167	-	μJ
E _{ts}	Total Switching Loss	<u>] </u>	-	752	-	μJ
T _{d(on)}	Turn-On Delay Time	V_{CC} = 400 V, I _C = 15 A, R _G = 4.7 Ω, V _{GE} = 15 V,	-	19.2	-	ns
Tr	Rise Time	$H_{G} = 4.7 \Omega_{2}, V_{GE} = 15 V,$ Inductive Load, $T_{C} = 175^{\circ}C$	-	9.6	-	ns
T _{d(off)}	Turn-Off Delay Time		-	115	-	ns
Τ _f	Fall Time	 	-	11.2	-	ns
Eon	Turn-On Switching Loss		-	448	-	μJ
E _{off}	Turn–Off Switching Loss	1	-	199	-	μJ
E _{ts}	Total Switching Loss	-	_	647	_	μJ

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
SWITCHING C	HARACTERISTICS					
T _{d(on)}	Turn–On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 30 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GE} = 15 \text{ V},$	-	20.8	-	ns
Tr	Rise Time	Inductive Load, $T_C = 175^{\circ}C$	-	16	-	ns
T _{d(off)}	Turn-Off Delay Time		-	106	-	ns
T _f	Fall Time		-	8.8	-	ns
Eon	Turn-On Switching Loss		-	942	-	μJ
E _{off}	Turn-Off Switching Loss		-	386	-	μJ
E _{ts}	Total Switching Loss		-	1328	-	μJ
Qg	Total Gate Charge	V _{CE} = 400 V, I _C = 60 A, V _{GE} = 15 V	-	79	-	nC
Q _{ge}	Gate to Emitter Charge	VGE = 13 V	-	22	-	nC
Q _{gc}	Gate to Collector Charge		-	27	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Symbol	Parameter	Test Co	Test Conditions			Max	Unit
V_{FM}	Diode Forward Voltage	I _F = 30 A	$T_{C} = 25^{\circ}C$	-	2.3	2.7	V
			T _C = 175°C	_	1.9	-	
E _{rec}	Reverse Recovery Energy	I _F = 30 A, dI _F /dt = 200 A/μs	T _C = 175°C	-	50	-	μJ
T _{rr}	Diode Reverse Recovery Time		$T_{C} = 25^{\circ}C$	-	34.6	-	ns
			T _C = 175°C	-	197	-	
Q _{rr}	Diode Reverse Recovery Charge		$T_{C} = 25^{\circ}C$	-	58.6	-	nC
			T _C = 175°C	-	810	-	

TYPICAL CHARACTERISTICS

Collector-Emitter Voltage, V_{CE} [V]

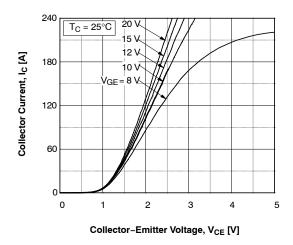


Figure 1. Typical Output Characteristics

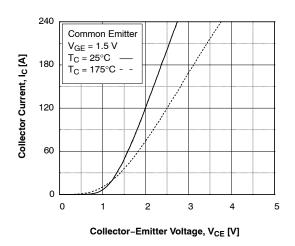


Figure 3. Typical Saturation Voltage Characteristics

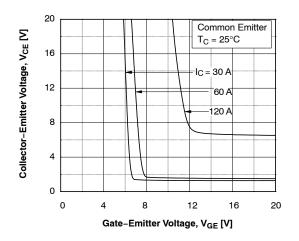


Figure 5. Saturation Voltage vs. V_{GE}

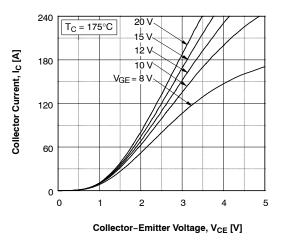
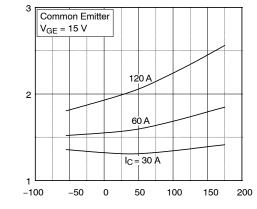


Figure 2. Typical Output Characteristics



Collector-Emitter Case Temperature, T_C [°C]

Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

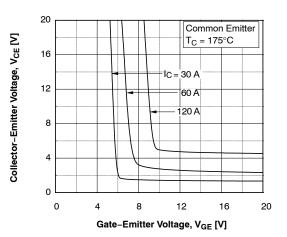
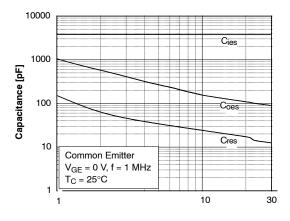


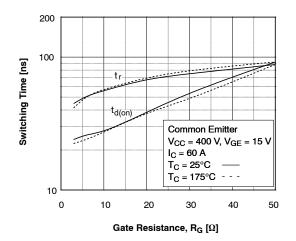
Figure 6. Saturation Voltage vs. V_{GE}

TYPICAL CHARACTERISTICS (Continued)

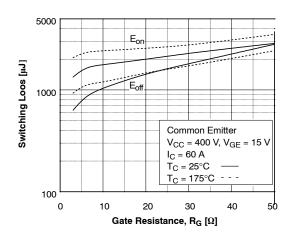


Collector-Emitter Voltage, V_{CE} [V]

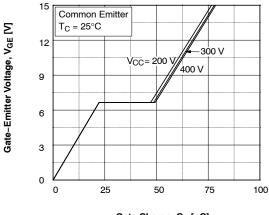
Figure 7. Capacitance Characteristics











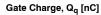


Figure 8. Gate Charge Characteristics

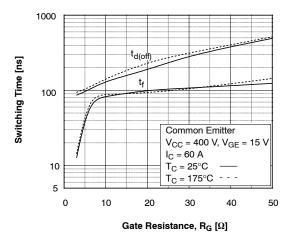


Figure 10. Turn-off Characteristics vs. Gate Resistance

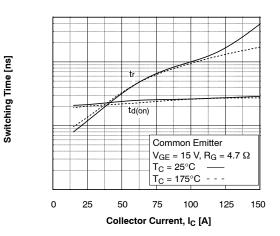
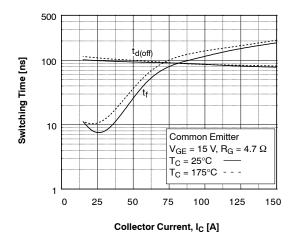
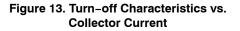
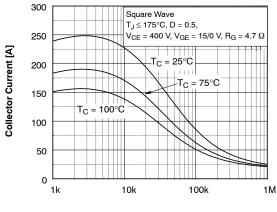


Figure 12. Turn-on Characteristics vs. Collector Current

TYPICAL CHARACTERISTICS (Continued)

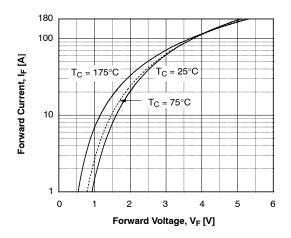




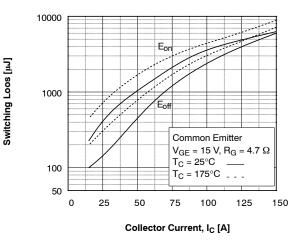


Switching Frequency, f[Hz]

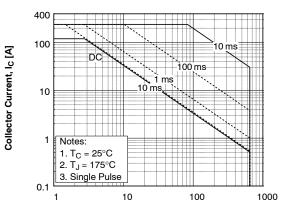
Figure 15. Load Current vs. Frequency











Collector-Emitter Voltage, V_{CE} [V]

Figure 16. SOA Characteristics

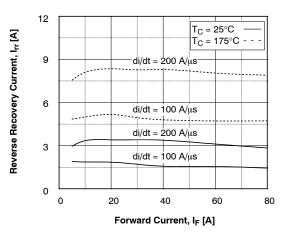


Figure 18. Reverse Recovery Current

TYPICAL CHARACTERISTICS (Continued)

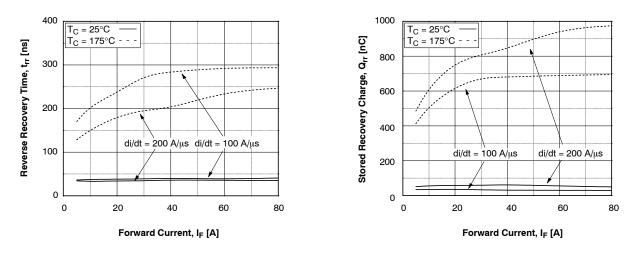
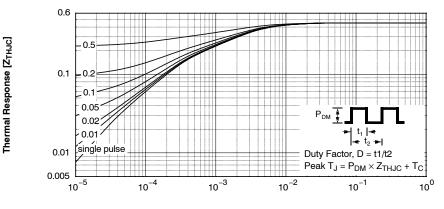


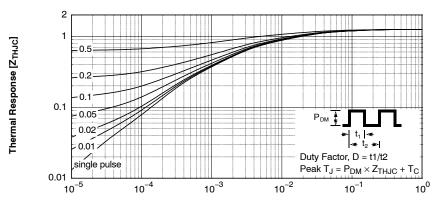
Figure 19. Reverse Recovery Time





Rectangular Pulse Duration [sec]

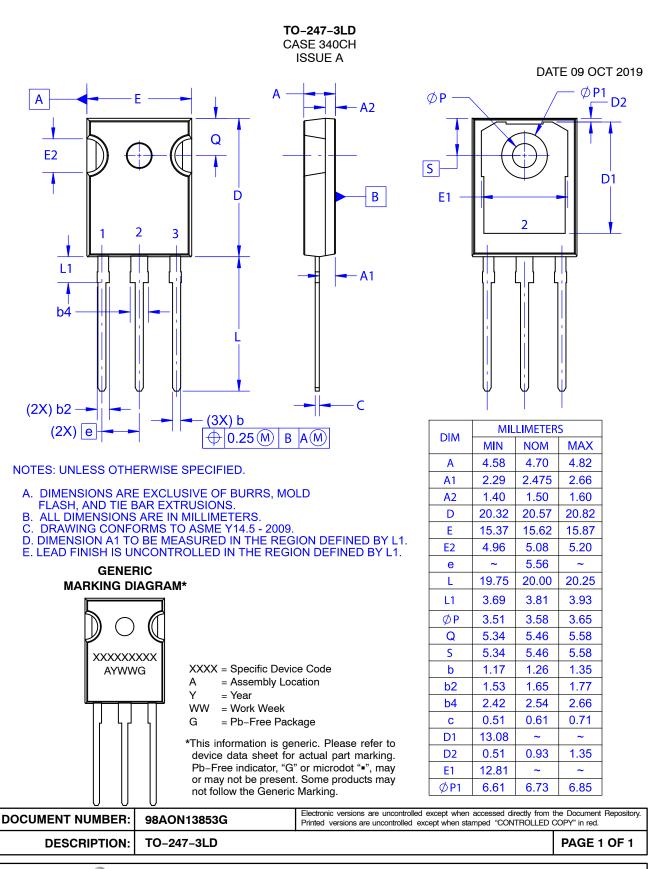
Figure 21. Transient Thermal Impedance of IGBT



Rectangular Pulse Duration [sec]

Figure 22. Transient Thermal Impedance of Diode





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